

Problem: Infalling structure has to pass *through* structure on CCD surface \implies loss of low energy response, also danger through destruction of CCD structure by cosmic rays...

Solution: Irradiate the back side of the chip. Deplete whole CCD-volume, transport electrons to pixels via adequate electric field ("backside illuminated CCDs")

Practical Implementation

XMM-Newton: EPIC-pn CCD



XMM-Newton (EPIC-MOS; Leicester): 7 single CCDs with 600 \times 600 pixels, mounting is adapted to curved focal plane of the Wolter telescope.

Practical Implementation

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Data Analysis

optical CCDs: mesure intensity \implies need *long* exposures X-ray CCDs: measure individual photons \implies need fast readout bright sources: several 1000 photons per second \implies readout in μ s!

In X-rays: spectroscopy possible. Typical resolution reached today:

$$\frac{\Delta E}{E} = 2.355 \sqrt{\frac{3.65 \,\mathrm{eV} \cdot F}{E}} \tag{5.8}$$

with $F \sim 0.1 \implies \sim 0.4\%$, so much better than gas detectors. Energy \propto number N of initial photoelectrons \implies Energy resolution (Poisson statistics!):

$$\frac{\Delta E}{E} \propto \frac{\Delta N}{N} = \frac{N^{1/2}}{N} = \frac{1}{N^{1/2}} \propto E^{-1/2}$$
(5.9)

For both optical and X-rays: sensitivity close to 100%

Si-based CCDs are currently the best available imaging photon detectors for optical and X-ray applications.



Data Analysis

Finite resolution of X-ray detectors has major implications for X-ray data analysis. Mathematical description of the X-ray measurement process:

$$n_{\rm ph}(c) = \int_0^\infty R(c, E) \cdot A(E) \cdot F(E) \, dE \tag{5.10}$$

where

- $n_{ph}(c)$: source count rate in channel c (counts s⁻¹),
- F(E): photon flux density (ph cm² s⁻¹ keV⁻¹),
- A(E): effective area (units: cm²),
- R(c, E): detector response (probability to detect photon of energy E in channel c).

X-Ray Data Analysis



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Effective Area of the Rossi X-ray Timing Explorer's Proportional Counter Array (Xe gas detector).



caused by escaping Xe Keta and Xe Llpha photons.

X-Ray Data Analysis

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Data Analysis

To analyze data: discretize Eq. (5.10):

$$S_{\rm ph}(c) = \Delta T \sum_{i=0}^{n_{ch}} A(E_i) R(c,i) F(E_i) \Delta E_i$$
(5.11)

where $N_{ph}(c)$: total source counts in channel c, ΔT : exposure time (s), $\mathbf{x}A(E_i)$: effective area in energy band i ("ancilliary response file", ARF), R(c, i): response matrix (RMF), $F(E_i)$: source flux in band (E_i, E_{i+i}) , ΔE_i : width of energy band. Because of background B(c) (counts), what is measured is

$$N_{\rm ph}(c) = S_{\rm ph}(c) + B(c)$$
 (5.12)

So estimated source count rate is

$$\tilde{S}_{ph}(c) = N_{ph}(c) - B(c)$$
 (5.13)

with uncertainty (Poisson!)

$$\sigma \tilde{S}_{\rm ph}(c) = \sqrt{N_{\rm ph}(c)^2 + B(c)^2}$$
(5.14)



Data Analysis

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To get physics out of measurement, need to find $F(E_i)$.

Big problem: In general, Eq. (5.11) is not invertible.

 $\Longrightarrow \chi^2$ -minimization approach

Use a model for the source spectrum, F(E; x), where x vector of parameters (e.g., source flux, power law index, absorbing column,...), and calculate predicted model counts, M(c; x), using Eq. 5.11).

Then form χ^2 -sum:

$$\chi^{2}(\boldsymbol{x}) = \sum_{c} \frac{\left(\tilde{S}_{\mathsf{ph}}(c) - M(c; \boldsymbol{x})\right)^{2}}{\sigma \tilde{S}_{\mathsf{ph}}(c)^{2}}$$
(5.15)

Then vary ${\pmb x}$ until χ^2 is minimal and perform statistical test based on χ^2 whether model $F(E;{\pmb x})$ describes data.

Programs used: XSPEC, ISIS

X-Ray Data Analysis

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Lockman-Hole with XMM-Newton: The Universe is full of AGN!

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Aschenbach, B., 1985, Rep. Prog. Phys., 48, 579